

US EPA ARCHIVE DOCUMENT

# Ion Mobility Analysis of Gaseous and Particulate Pollutants

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# The Ideal Aerosol Chemical Analysis Instrument

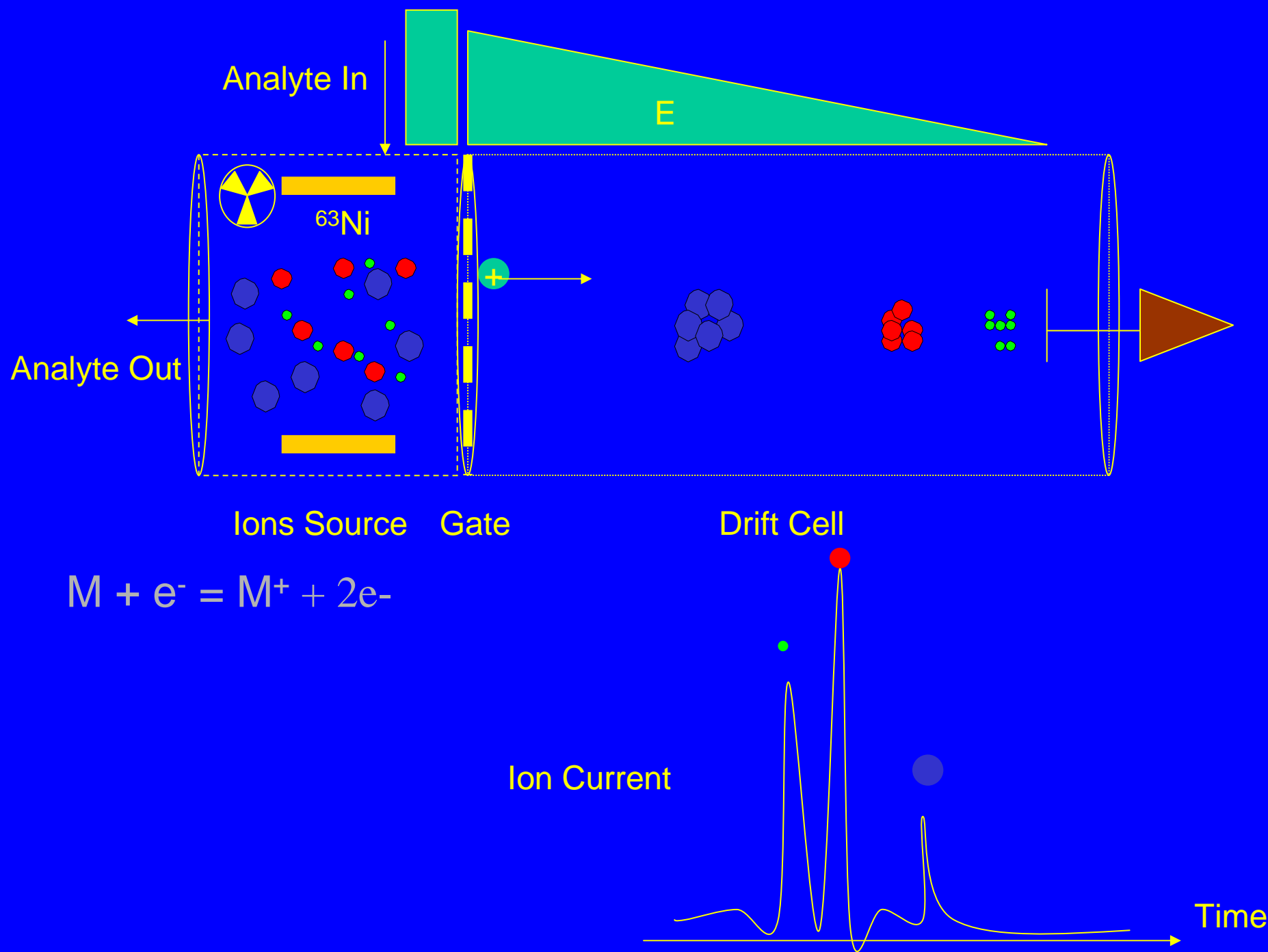
- Goals
  - High Time Resolution
  - Inexpensive capital and operating costs
    - Nice goal in its own right
    - Allows high spatial resolution
  - Chemical Speciation
    - Goes along with cheap - obviates the need for multiple toys
    - Nail those organics
- Instrument Characteristics
  - Fast = real time, spectrometry
  - Cheap = No Vacuum
  - Chemical Analysis = a separation technology

# A separation technology: Ion electrical mobility

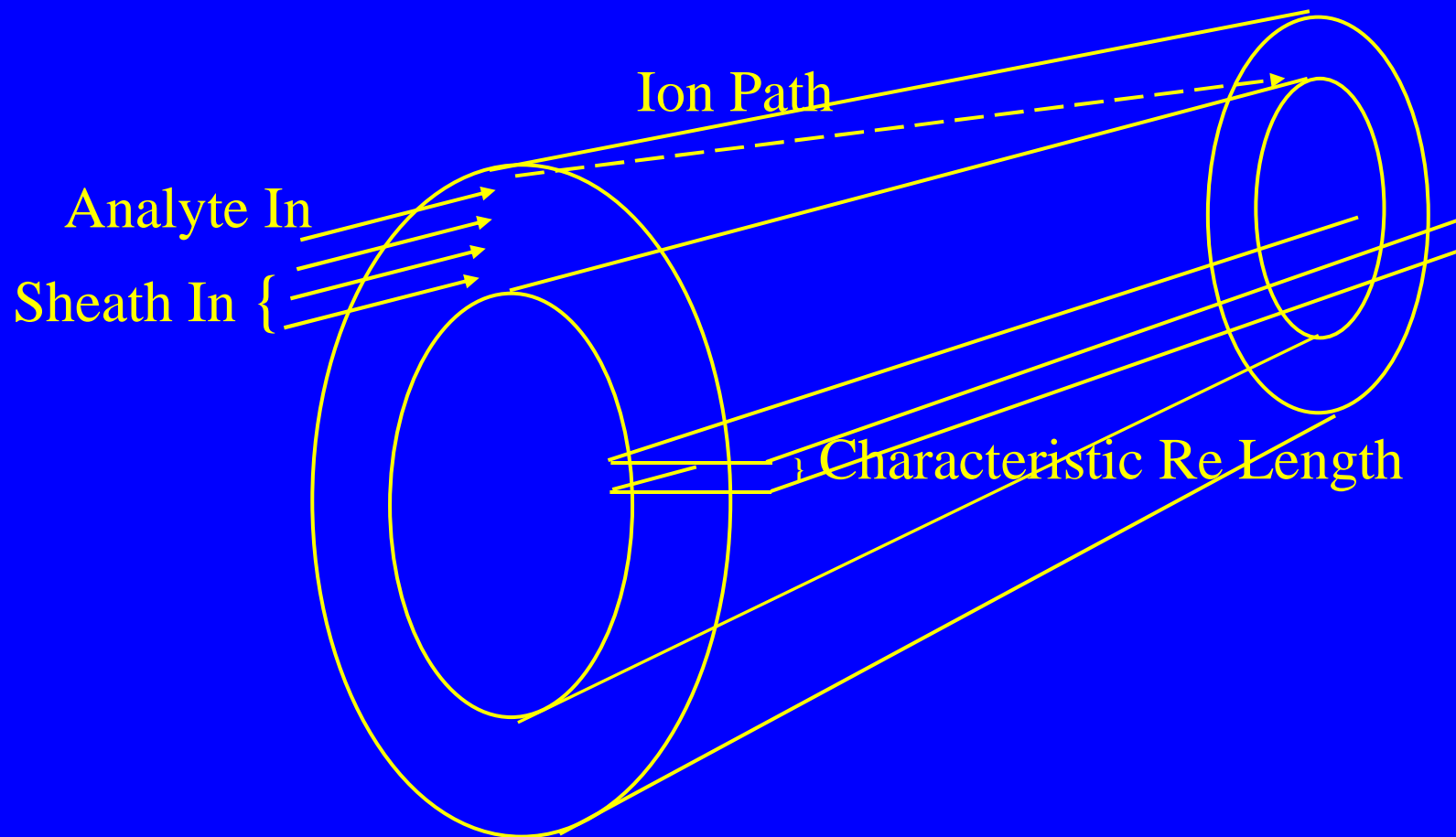
- $V_{\text{drift}} = ZE$  is the drift velocity [cm/s]
- $Z$  is electric mobility [cm/s]/[volt/cm]
- $E$  is electric field strength [volt/cm]
- Einstein Relation between mobility and diffusivity,  $D$ , limits resolution
  - $D = kTZ/q$
  - $q$  is charge - usually +/-1 for molecular ions
- $Z$  is function of ion or particle size, charge,  $E$ !
  - Ion mobility range: 0.5-3.0
  - Particle mobility range:  $10^{-2}$ - $10^{-5}$

# Ion Mobility Spectrometry

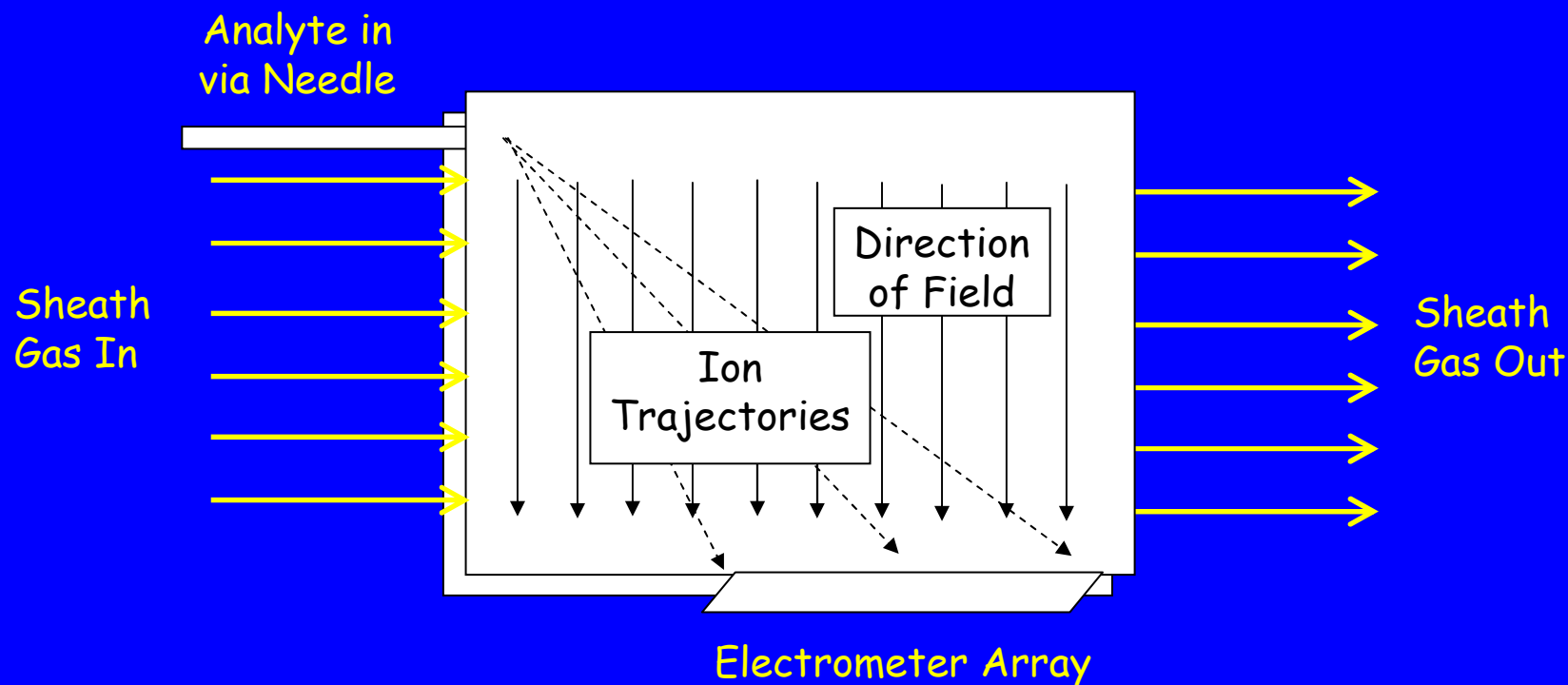
- Time-of-Flight (temporal separation)
  - Used and studied for decades
    - See Eiceman and Karpas, second edition
    - Inexpensive, fast, ion mobility separation
  - Currently used in airports, by the military
    - Detection of explosive, toxins, etc.
  - Limited application in the atmosphere, so far
    - Resolution - sensitivity trade-offs
    - Water/temperature/analyte interference
    - Not very quantitative



# DMA Technology



# Cross Flow - Ion Mobility Spectrometry CF-IMS Schematic



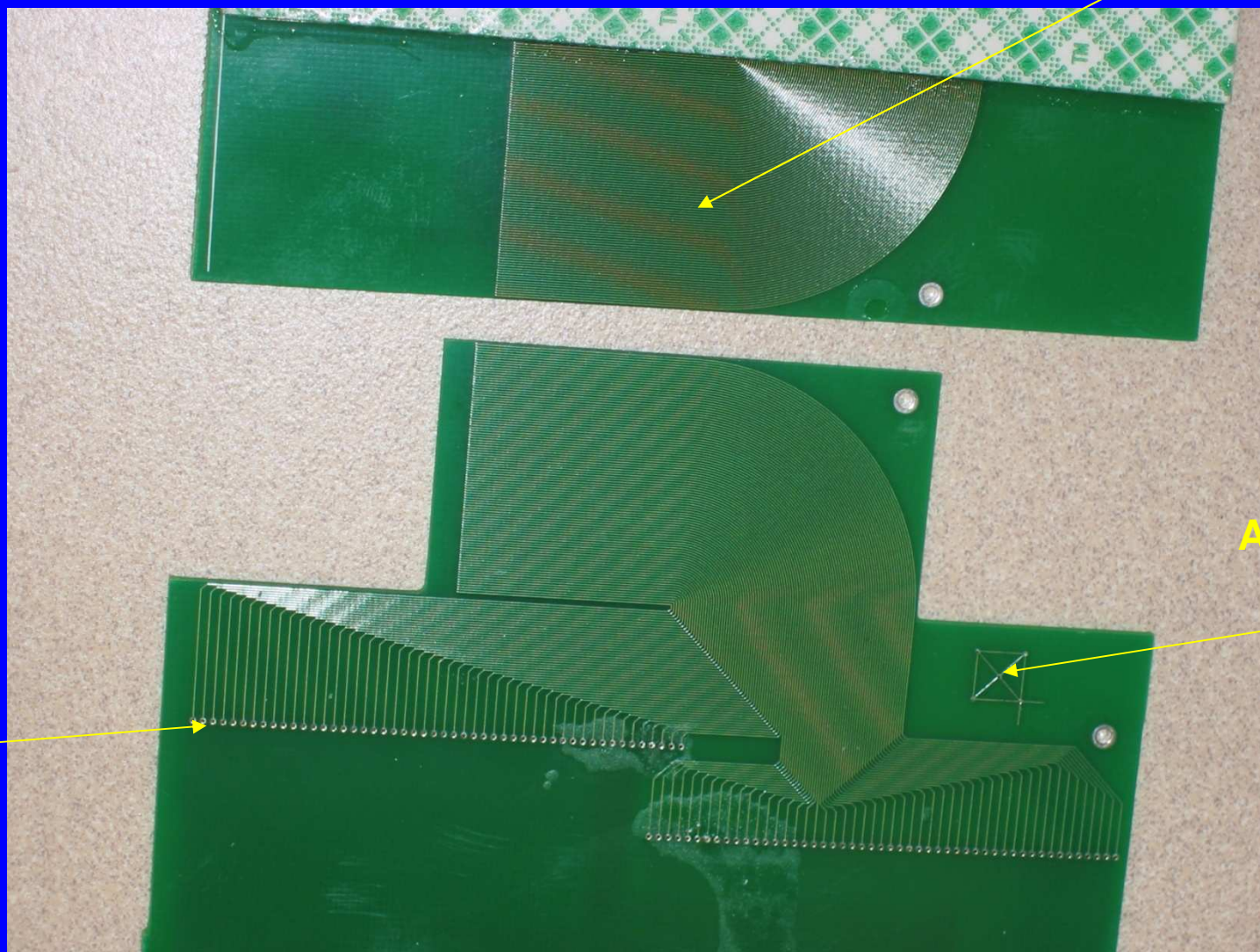


# Drift Cell Open Showing Traces

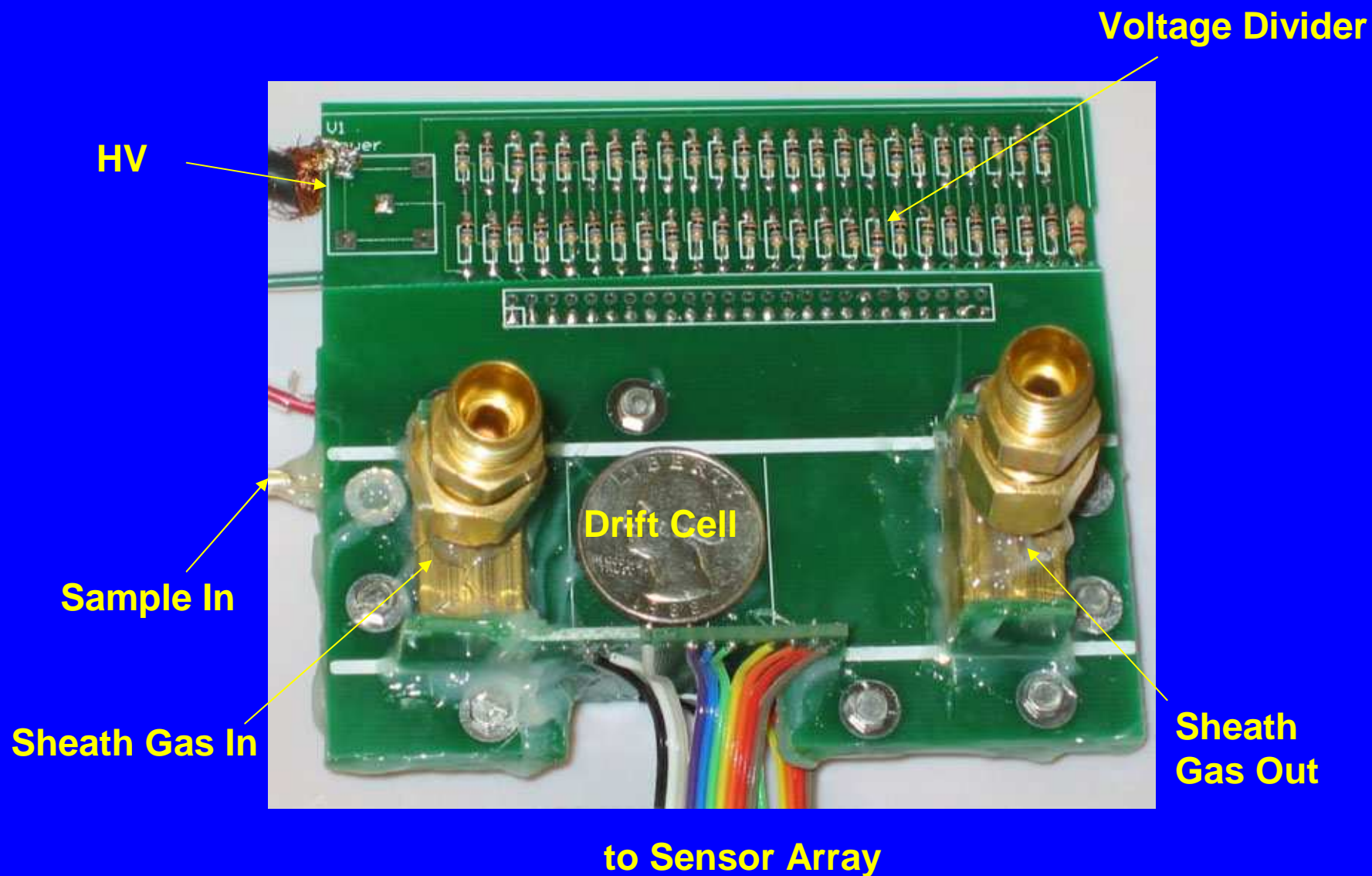
100 1"x0.005" Copper

Alignment  
Mark

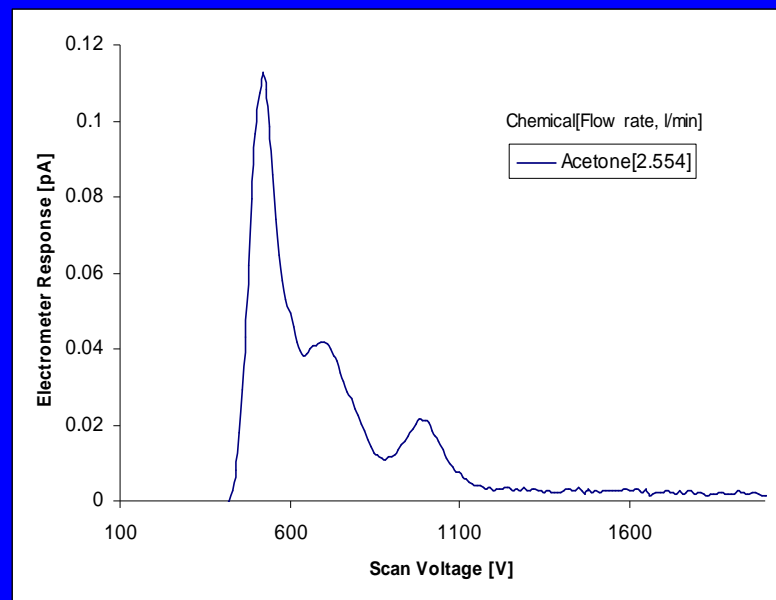
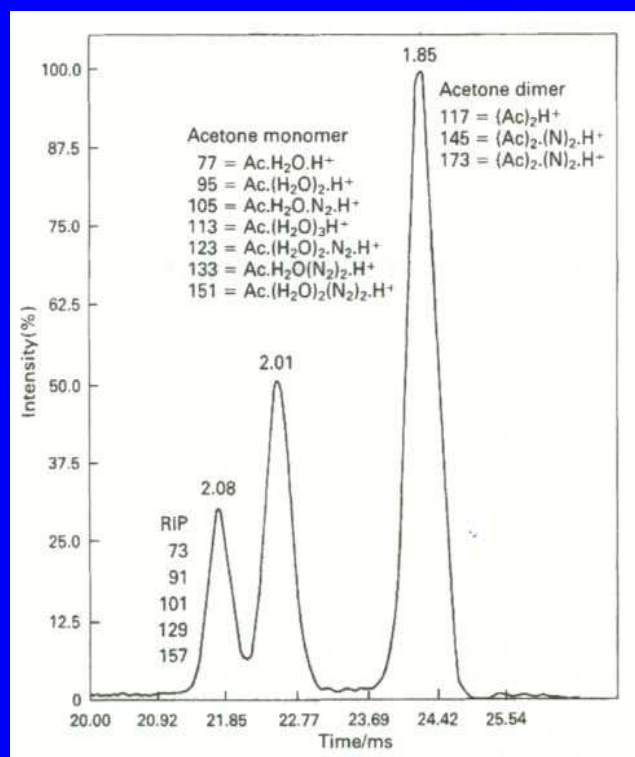
Via



# Low Resolution Prototype



# Acetone Ion Mobility Spectrum



Zhang, M. and A.S. Wexler. Cross Flow Ion Mobility Spectrometry: Theory and Initial Prototype Testing. *Int'l J. Mass Spectrometry* 258:13-20, 2006.

# CF-IMS

- What's Next?
  - High Resolution
  - Electrometer Array
  - Gas and Particle Analysis
  - Manufacturability

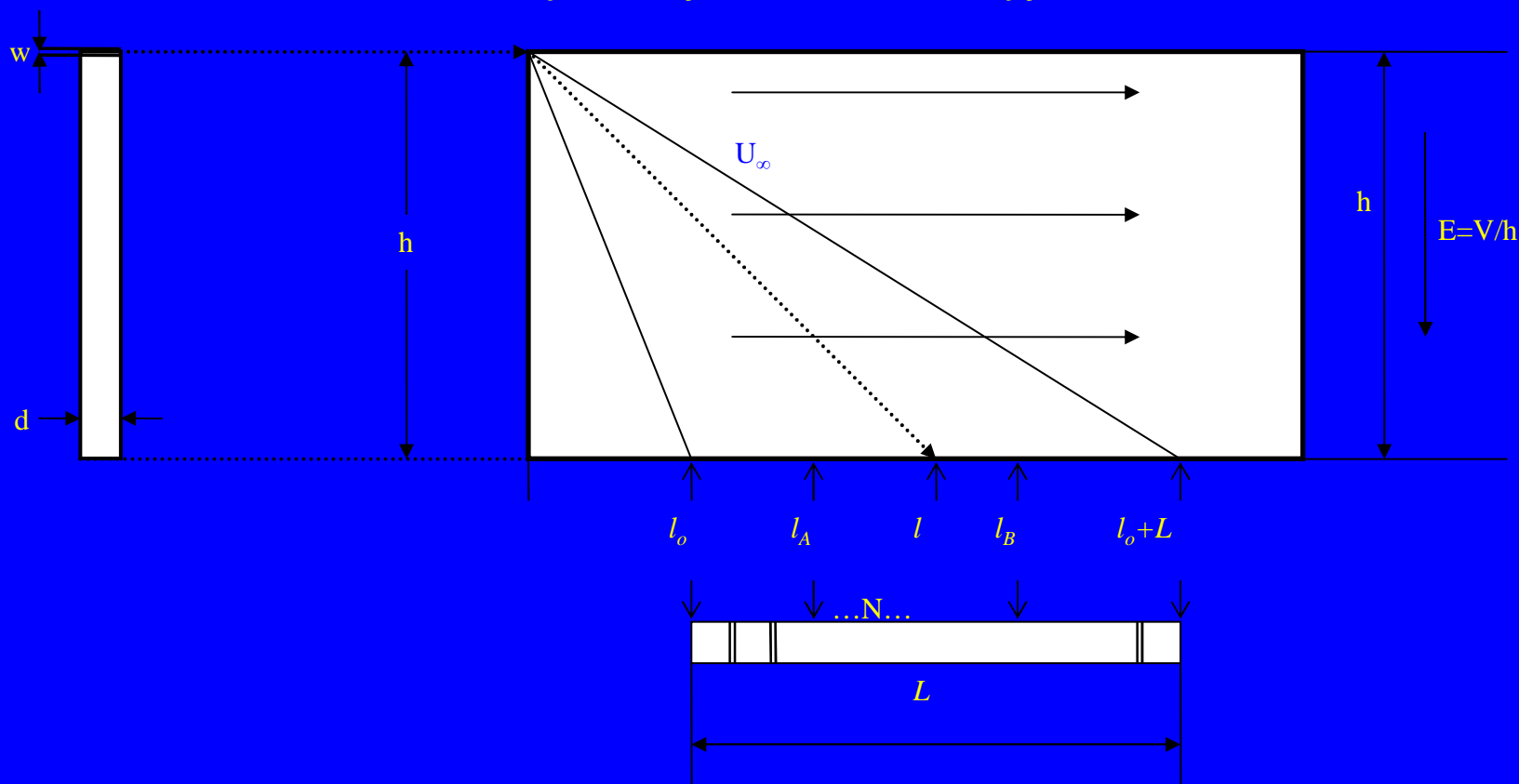


# CF-IMS Resolution

- Resolution Challenges
  - Diffusion
  - Geometric Aberration
  - Parabolic Flow Profile
- Resolution-Sensitivity Trade-offs
  - Needle Width and Height
  - Electrometer Pad Size
- Sensitivity Challenges
  - Electrometer Fantastic-ness

# CF-IMS Resolution: Needle width and diffusion

$$R^{-1} = \frac{w}{h} + \frac{\Delta l}{l} + \frac{2\delta_x \sqrt{h^2 + l^2}}{hl}$$



## CF-IMS Resolution: Dispersion in the Gap

- Flow in gap is parabolic
- Center faster than periphery dispersing ions
  - Center ions reach their electrode at  $l(0)$
  - Ions  $x$  from center:  $l(x) = l(0)[1 - (x / d/2)^2]$
- Resolution,  $R^{-1}$ , is
  - $R^{-1} = \{l(0) - l(x)\} / l(0) = (x / d/2)^2$



# CF-IMS Design Criteria

- Flow in gap is laminar
- Field gradient less than break down voltage
- Same needle and sheath gas velocities
  - Minimize eddies
- Balance Sources of Resolution Loss
  - Dispersion
  - Diffusion
  - Needle size
    - Geometric aberration
    - Flow dispersion
  - Electrometer pad size



# CF-IMS Low and High Resolution Specifications

Prototypes	High Resolution	Low Resolution
Dimension L×W×H[cm]	20×10×0.1	2.5×2.5×0.16
Sample Flow Rate [cc/s]	4.2	5
Sheath Gas Flow Rate [l/min]	110	3-5
Recirculation Blower Power [W]	0.8	N/A
Mobility Range [cm <sup>2</sup> /v-s]	1.5-3.0	1.0-2.5
Molar Mass Range	30-600 Dalton	30-600 Dalton
Sample Flow Pressure Drop [Pa]	64	<1
Sheath Flow Pressure Drop [Pa]	435	<1
Power Supply Voltage (kV)	10	5
Sensor Length [cm]	10	2.54
Electrometer Pad Size $L \times d$ [cm×cm]	0.02×0.1	0.08×0.16
Mobility Resolution	92	10

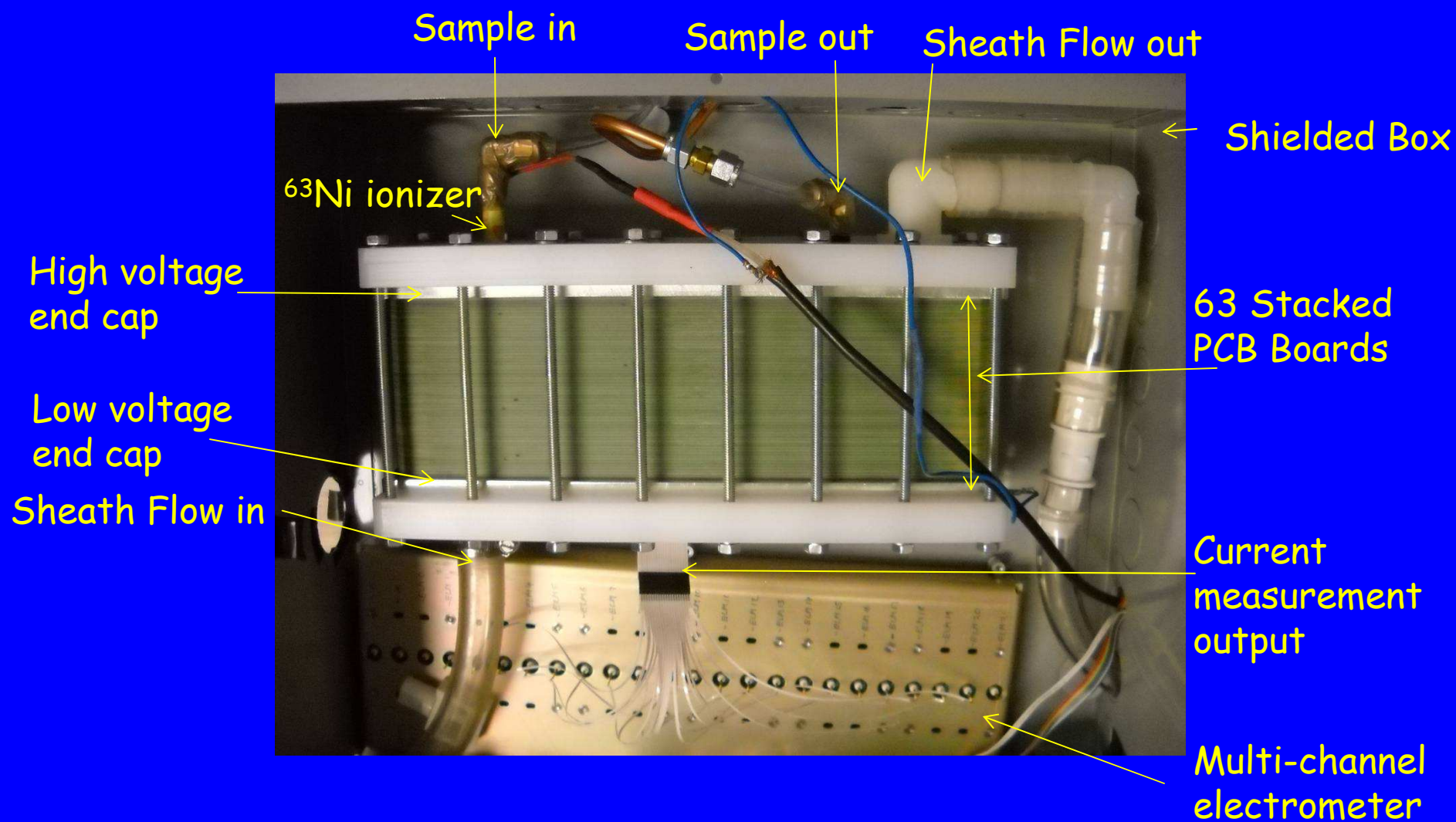
# CF-IMS Electrometer Array

-----  
Perkin Elmer  
XL-1256

Table 2. Specifications

Description	Min	Nom	Max	Units
Saturation charge	2.5 <sup>5</sup>		40.5 <sup>6</sup>	pC
Parasitic input capacitance (to V <sub>SS</sub> )		4.5		pF
Input leakage current (per channel)		±100	±250	fA
Charge conversion	10 <sup>6</sup>		160 <sup>5</sup>	nV/e-
Integration amplifier slew rate		1.0		V/μsec
Output clocked video level (V <sub>REF</sub> =5V)				
Q: 0 to QSAT	3.0	2.5	1.5	V
Q: 0 to -QSAT	6.5	7.5	8.5	V
Output quiescent video level		V <sub>REF</sub>		V
Output video impedance		1.5		K ohm
Output video readout frequency			1.0	MHz
VoutS output variation <sup>1</sup>		15		mV
VoutR output variation <sup>1</sup>		15		mV
Video output differential offset <sup>2</sup>		40		mV
Digital outputs (EOL signal) high level	3.5		5.5	V
Digital outputs (EOL signal) low level	GND		GND+0.3	V
Quiescent V <sub>DD</sub> current (I <sub>DD</sub> )		40	45	mA
Clocked V <sub>DD</sub> current		50	55	mA
PSRR (@1kHz & 120 pF C <sub>IN</sub> ) To V <sub>SS</sub>			-25	dB
PSRR (@1kHz & 120 pF C <sub>IN</sub> ) To V <sub>DD</sub>			-25	dB
Operating potential (V <sub>DD</sub> -V <sub>SS</sub> )	9.5	10	12.5	V
Reference potential		5	7	V
Digital input levels-high level	3.5	5	5	V
Digital Input levels-low level	GND	GND	0.4	V
Bias resistor current		16		μA
Operating temperature range	0		70	°C
Noise @25 pFC <sub>IN</sub> <sup>3</sup>				
Input referred noise		5		μVms
		29		rms electrons
System noise		70		μVms
		450		rms electrons
Dynamic range <sup>4</sup>	90			dB

# CF-IMS High Resolution Prototype

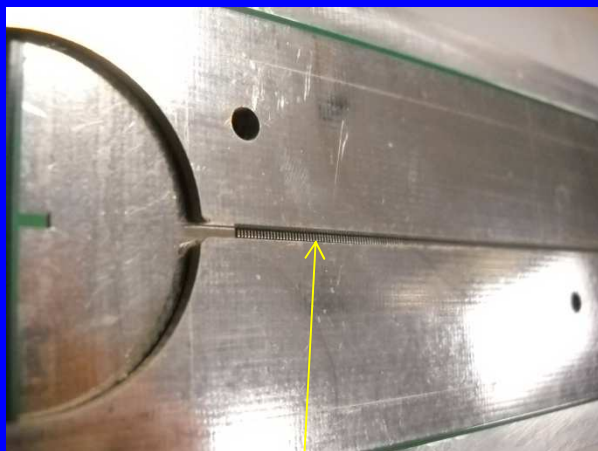


# CF-IMS High Resolution Prototype Components

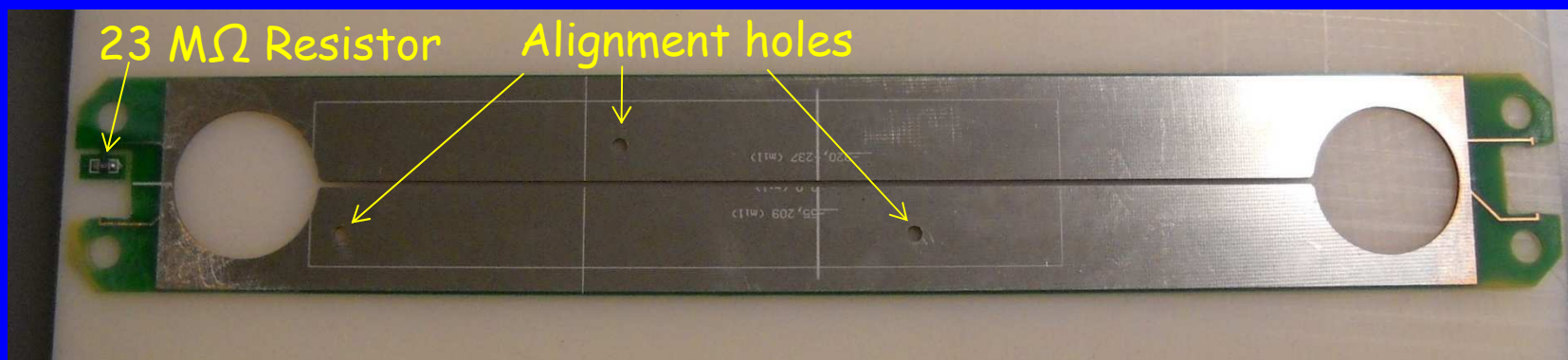




# CF-IMS High Resolution Prototype Components



Electrometer pads



PCB Board

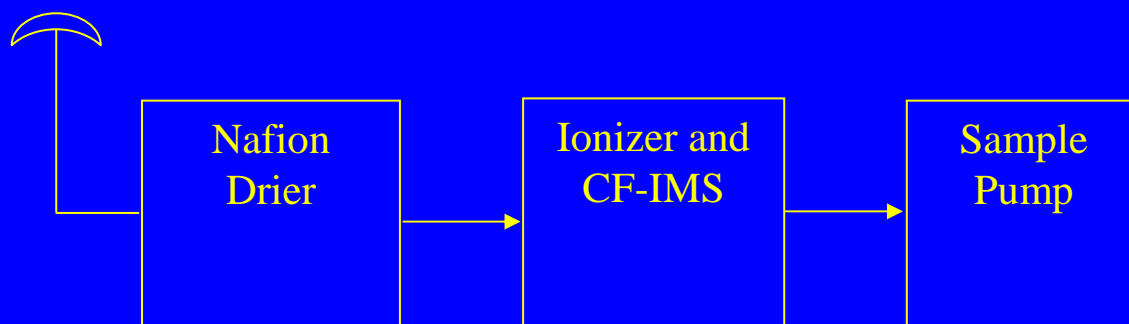
# Manufacturability

- ↑ High Voltage / Automatic Voltage Divider
- ↑ E-field parallel to flow channel
- ↓ Leaks - Sleeve fixes that

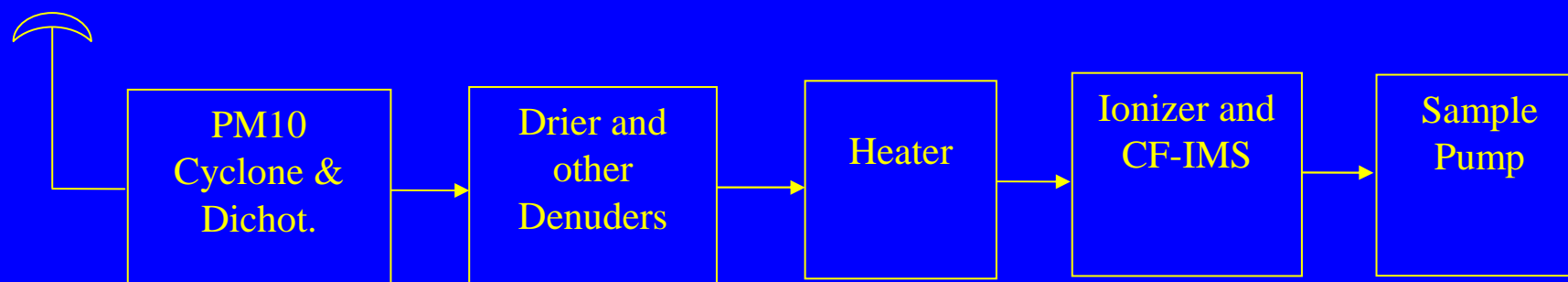
# Current (literally) Issues

- Leaks
  - Seem to have leaks between the boards fixed
  - Seem to have blower leaks fixed too
- Current
  - 10 mCi should produce ~20-30 nA current
  - Diffusion losses take this to ~7-10 nA
  - Actual is about 1 pA ( $10^4$  loss)
  - Measurement and SIMION calcs show low loss in IMS cell
  - When we find loss, pad current will be ~40 pA

# CF-IMS - Instrument Realizations



Schematic for analysis of gas phase precursors



Schematic for analysis of semi-volatile particulate compounds



# How much might it cost?

- Electrometer arrays 2@ \$300 = \$600
- Electrometer-PC interface \$400
- Pumps \$200
- PC boards \$200
- Endcaps \$100
- 6" ruler \$1
- Total parts cost \$1501
- Manufacturer's markup \$6000
- Total list price \$7501
- Double for particle conditioning add-ons

# Thank You

- Mang Zhang and Sonya Collier
  - For doing all the work
- Dreyfus Foundation, CARB and EPA
  - For supporting this work
- You
  - For staying awake
- Questions?